

Search Notes

Application/Control No.

10/694,017

Examiner

Chen-Wen Jiang

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

3744

SEARCHED

Class	Subclass	Date	Examiner
62	271		
	419		
	93		
	94		
	406		
	410		
	412	9/21/2005	CJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
62	271	9/21/2005	CJ

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Searched Inventor Searched	9/21/2005	CJ